

Product Summary

BV _{SS}	R _{SS(ON)} Typ	I _S Max T _A = +25°C
12V	2.5mΩ @ V _{GS} = 3.8V	23.6A

Description

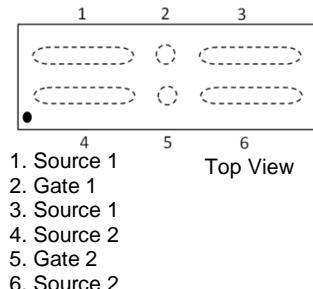
This new generation MOSFET is designed to minimize the on-state resistance (R_{SS(ON)}) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- Battery Management
- Load Switch
- Battery Protection



X3-DSN3518-6 (Type B)



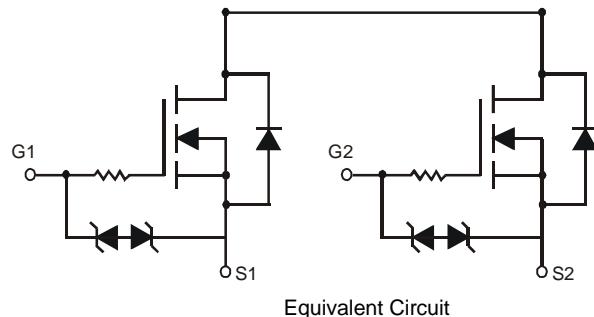
Features

- CSP with Footprint 3.54mm x 1.77mm
- Height = 0.21mm for Low Profile
- ESD Protection of Gate
- **Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)**
- **Halogen and Antimony Free. "Green" Device (Note 3)**
- For automotive applications requiring specific change control (i.e. parts qualified to AEC-Q100/101/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please [contact us](#) or your local Diodes representative.

<https://www.diodes.com/quality/product-definitions/>

Mechanical Data

- Case: X3-DSN3518-6
- Terminal Connections: See Diagram Below
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish — NiPdAu. Solderable per MIL-STD-202, Method 208
- Weight: 0.0026 grams (Approximate)



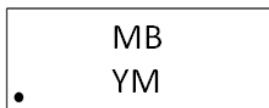
Ordering Information (Note 4)

Part Number	Case	Packaging
DMN13M9UCA6-7	X3-DSN3518-6 (Type B)	3000/Tape & Reel

Notes:

1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
2. See <https://www.diodes.com/quality/lead-free/> for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
4. For packaging details, go to our website at <https://www.diodes.com/design/support/packaging/diodes-packaging/>.

Marking Information



MB = Product Type Marking Code
 YM = Date Code Marking
 Y or Ȳ = Year (ex: G = 2019)
 M or M̄ = Month (ex: 9 = September)

Date Code Key

Year	2015	2016	2017	2018	2019	2020	2021
Code	C	D	E	F	G	H	I
Month	Jan	Feb	Mar	Apr	May	Jun	Jul
Code	1	2	3	4	5	6	7
Month	Aug	Sep	Oct	Nov	Dec		
Code	8	9	O	N	D		

Maximum Ratings (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic			Symbol	Value	Unit
Source-Source Voltage			V_{SSS}	12	V
Gate-Source Voltage			V_{GSS}	± 8	V
Continuous Source Current (Note 5) $V_{GS} = 4.5\text{V}$	Steady State	$T_A = +25^\circ\text{C}$ $T_A = +70^\circ\text{C}$	I_S	23.6 18.9	A
Continuous Source Current (Note 5) $V_{GS} = 2.5\text{V}$	Steady State	$T_A = +25^\circ\text{C}$ $T_A = +70^\circ\text{C}$	I_S	16.8 13.4	A
Pulsed Source Current (Note 6)			I_{SM}	100	A

Thermal Characteristics

Characteristic			Symbol	Value	Unit
Power Dissipation (Note 7)			P_D	1.05	W
Thermal Resistance, Junction to Ambient @ $T_A = +25^\circ\text{C}$ (Note 7)			$R_{\theta JA}$	120.7	$^\circ\text{C}/\text{W}$
Power Dissipation (Note 5)			P_D	2.67	W
Thermal Resistance, Junction to Ambient @ $T_A = +25^\circ\text{C}$ (Note 5)			$R_{\theta JA}$	46.8	$^\circ\text{C}/\text{W}$
Operating and Storage Temperature Range			T_J, T_{STG}	-55 to +150	$^\circ\text{C}$

Electrical Characteristics (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Source-Source Breakdown Voltage	BV_{SSS}	12	—	—	V	$V_{GS} = 0\text{V}, I_S = 1\text{mA}$
Zero Gate Voltage Source Current $T_J = +25^\circ\text{C}$	I_{SSS}	—	—	1	μA	$V_{SS} = 10\text{V}, V_{GS} = 0\text{V}$
Gate-Source Leakage	I_{GS}	—	—	± 10	μA	$V_{GS} = \pm 8\text{V}, V_{SS} = 0\text{V}$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	$V_{GS(TH)}$	0.5	—	1.3	V	$V_{SS} = 6\text{V}, I_S = 1\text{mA}$
Static Source-Source On-Resistance	$R_{SS(ON)}$	1.2	2.3	3.2	$\text{m}\Omega$	$V_{GS} = 4.5\text{V}, I_S = 5\text{A}$
		1.2	2.4	3.2		$V_{GS} = 4.0\text{V}, I_S = 5\text{A}$
		1.3	2.5	3.4		$V_{GS} = 3.8\text{V}, I_S = 5\text{A}$
		1.3	2.7	4.6		$V_{GS} = 3.1\text{V}, I_S = 5\text{A}$
		1.4	3.0	6.5		$V_{GS} = 2.5\text{V}, I_S = 5\text{A}$
Diode Forward Voltage	V_{SS}	—	0.7	1.2	V	$V_{GS} = 0\text{V}, I_S = 3\text{A}$
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C_{iss}	—	3315	—	pF	$V_{SS} = 6\text{V}, V_{GS} = 0\text{V}, f = 1.0\text{MHz}$
Output Capacitance	C_{oss}	—	850	—		
Reverse Transfer Capacitance	C_{rss}	—	248	—		
Total Gate Charge	Q_g	—	56.5	—	nC	$V_{SS} = 6\text{V}, V_{GS} = 4.5\text{V}, I_S = 27\text{A}$
Gate-Source Charge	Q_{gs}	—	8.8	—		
Gate-Drain Charge	Q_{gd}	—	13.3	—		
Gate Charge at V_{TH}	$Q_{g(TH)}$	—	6.9	—		
Turn-On Delay Time	$t_{D(ON)}$	—	603	—	ns	$V_{SS} = 6\text{V}, V_{GS} = 4.5\text{V}, I_S = 3\text{A}$
Turn-On Rise Time	t_r	—	1694	—		
Turn-Off Delay Time	$t_{D(OFF)}$	—	4749	—		
Turn-Off Fall Time	t_f	—	6208	—		

Notes: 5. Device mounted on FR-4 material with 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu.

6. Repetitive rating, pulse width limited by junction temperature.

7. Device mounted on FR-4 PCB with minimum recommended pad layout, single sided.

8. Short duration pulse test used to minimize self-heating effect.

9. Guaranteed by design. Not subject to production testing.

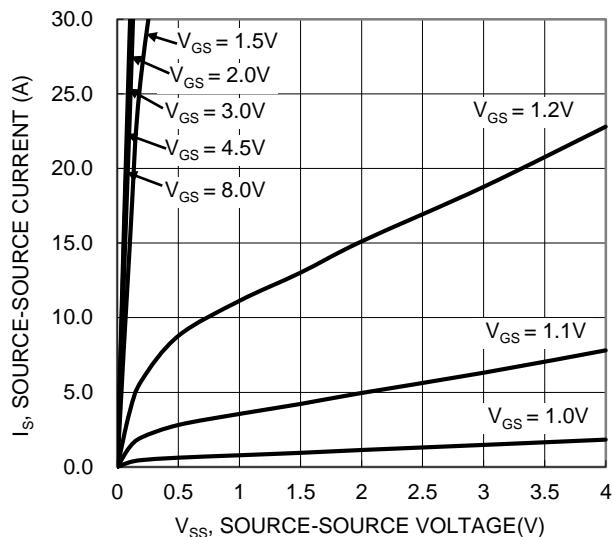


Figure 1. Typical Output Characteristic

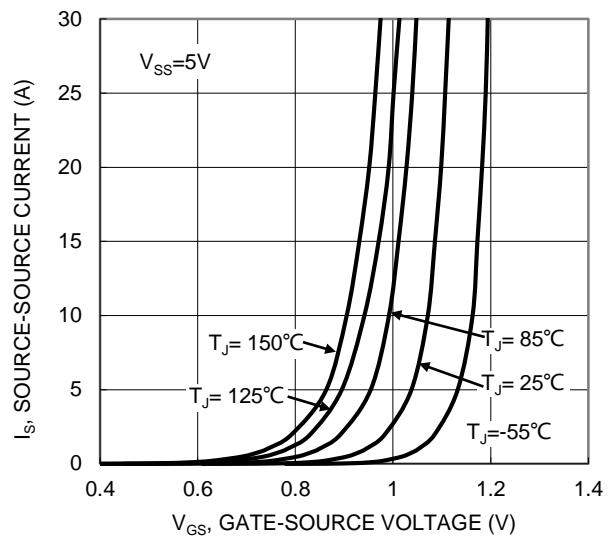


Figure 2. Typical Transfer Characteristic

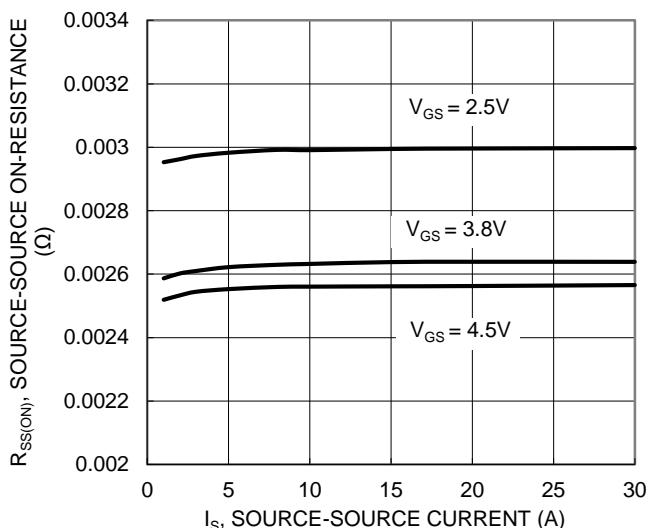


Figure 3. Typical On-Resistance vs. Source Current and Gate Voltage

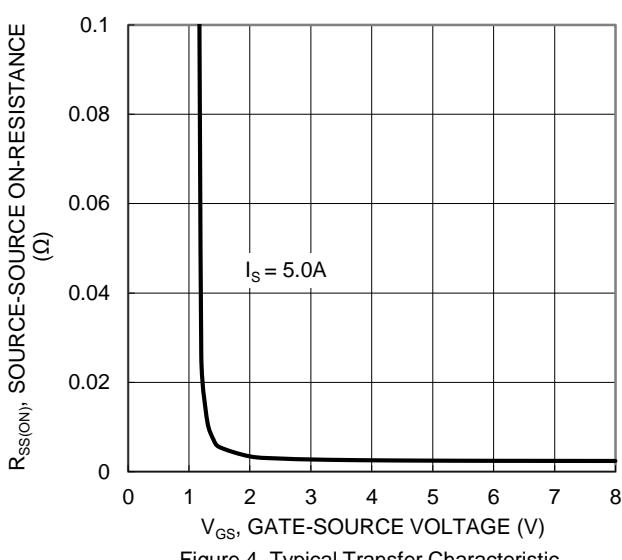


Figure 4. Typical Transfer Characteristic

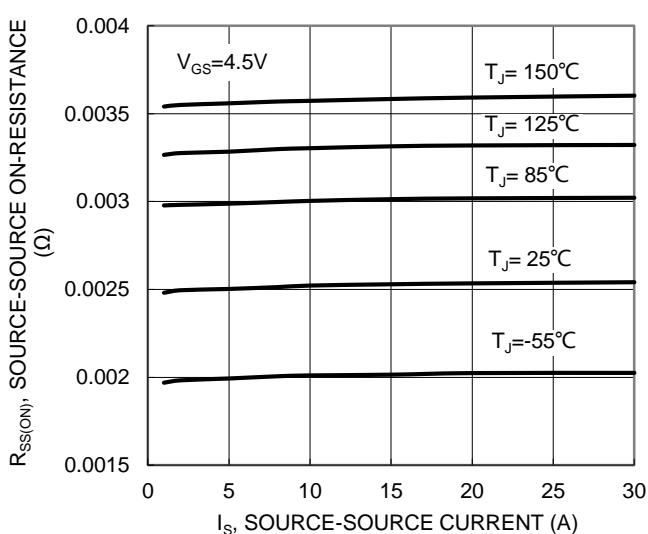


Figure 5. Typical On-Resistance vs. Source Current and Junction Temperature

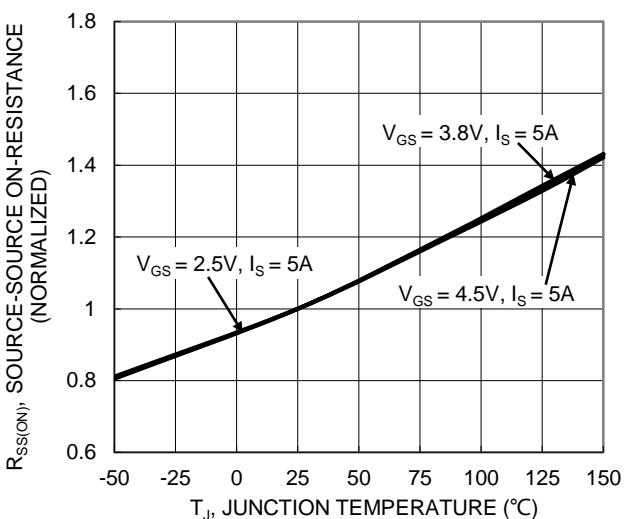


Figure 6. On-Resistance Variation with Junction Temperature

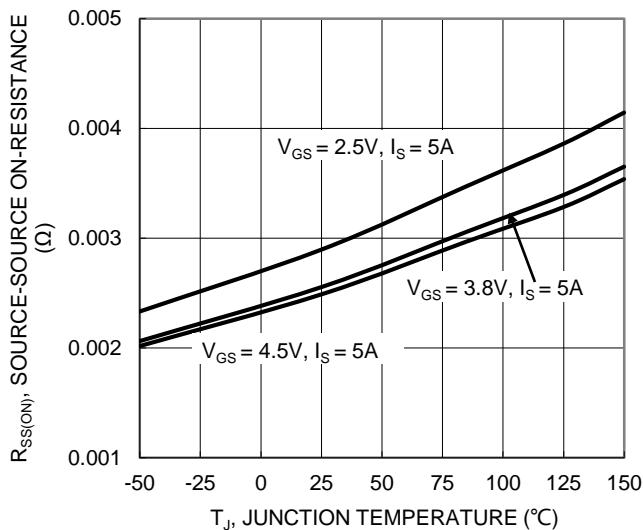


Figure 7. On-Resistance Variation with Junction Temperature

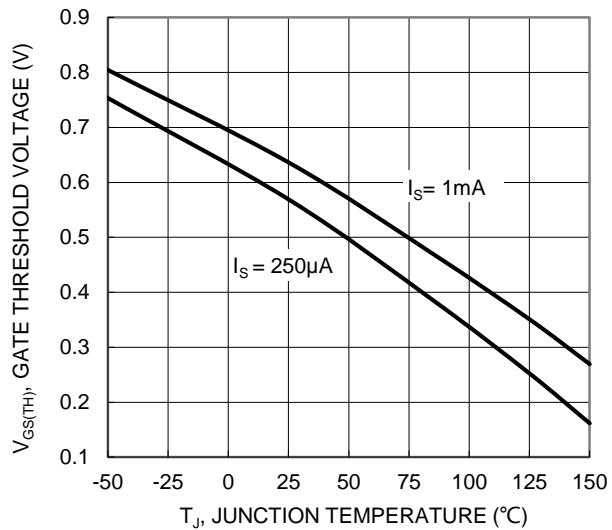


Figure 8. Gate Threshold Variation vs. Junction Temperature

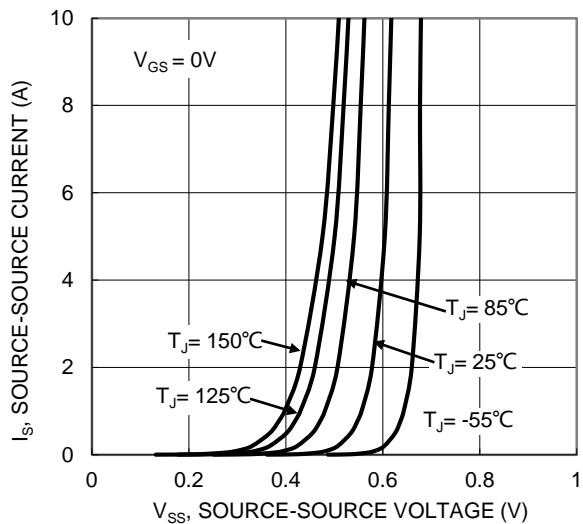


Figure 9. Diode Forward Voltage vs. Current

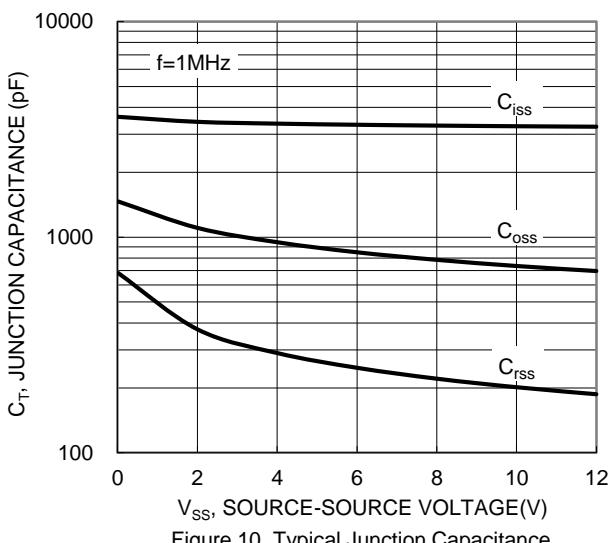


Figure 10. Typical Junction Capacitance

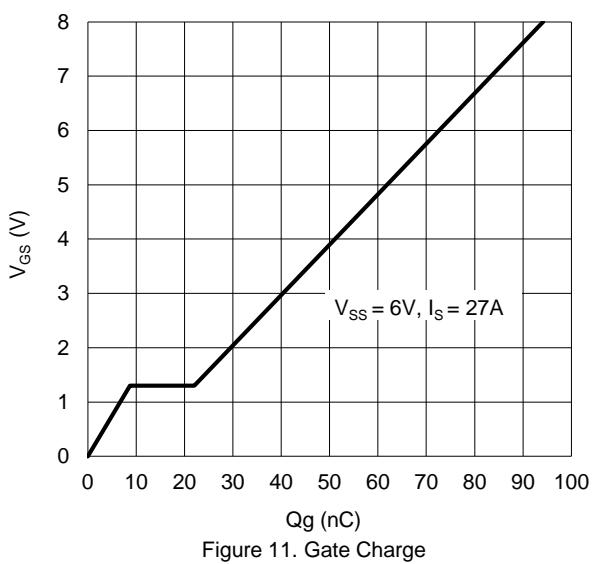


Figure 11. Gate Charge

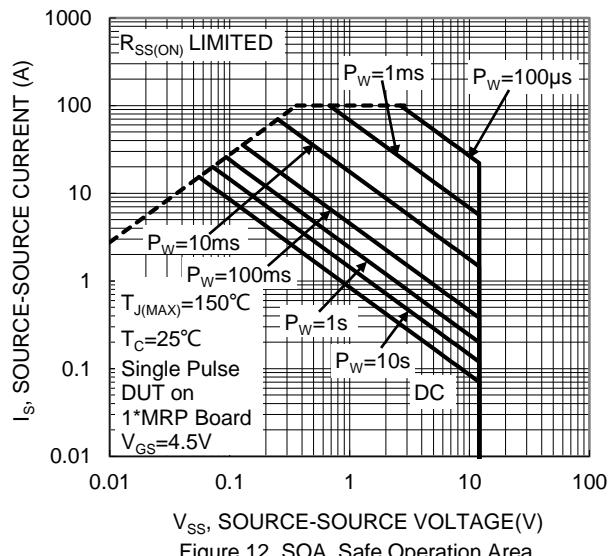


Figure 12. SOA, Safe Operation Area

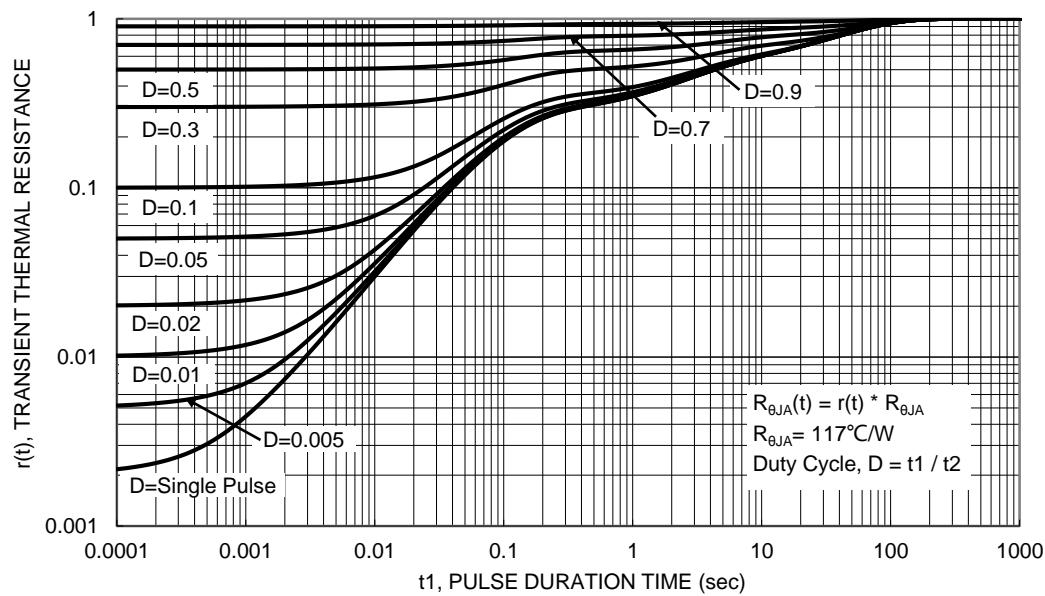
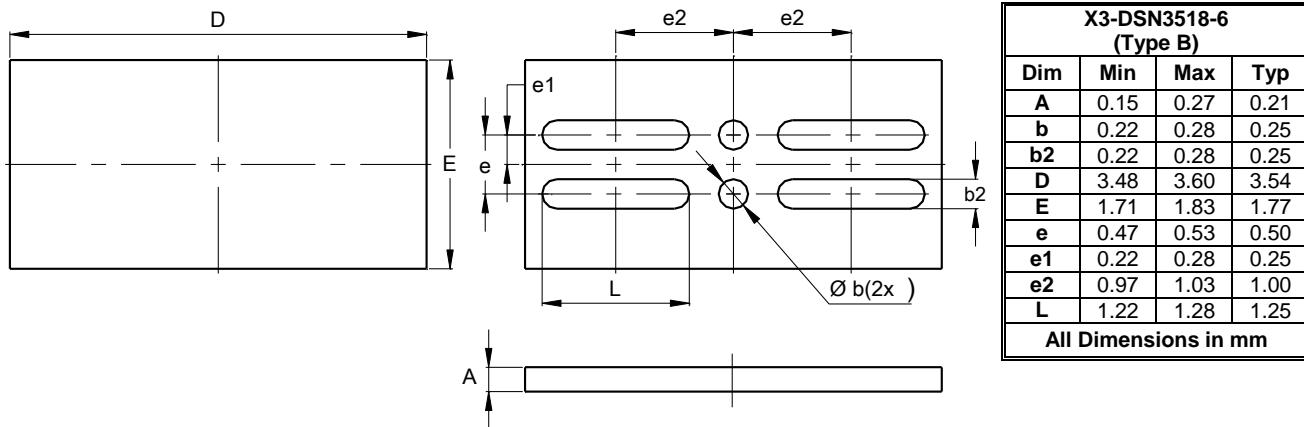


Figure 13. Transient Thermal Resistance

Package Outline Dimensions

Please see <http://www.diodes.com/package-outlines.html> for the latest version.

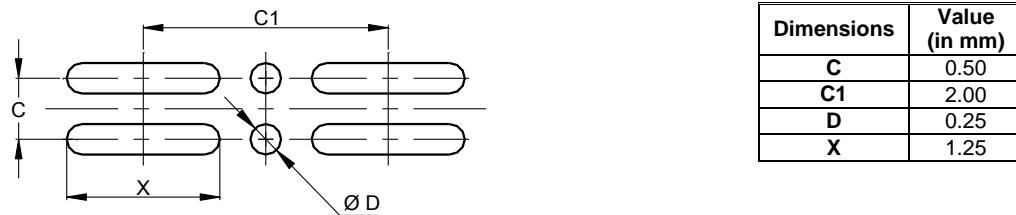
X3-DSN3518-6 (Type B)



Suggested Pad Layout

Please see <http://www.diodes.com/package-outlines.html> for the latest version.

X3-DSN3518-6 (Type B)



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